


Search Notes 	Application/Control No. 10527567	Applicant(s)/Patent Under Reexamination SUTTON ET AL.
	Examiner Jaeyun Lee	Art Unit 1791

SEARCHED

Class	Subclass	Date	Examiner
264	211	3/13/08	ld
264	148	11/6/2008	/JL/

SEARCH NOTES

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Updated EAST search (USPAT, US-PGPUB, EPO, JPO, DERWENT, FPRS, USOCR)	1/12/2010	/JL/
text search	1/12/2010	/JL/
Consulted Primary Examiner Jeff Aftergut	1/12/2010	/JL/

INTERFERENCE SEARCH

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